

Product Summary

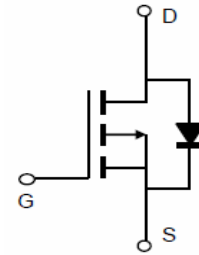
| Part # | V_{DS} | $R_{DS(on).typ}$ (@ $V_{GS}=10V$) | $R_{DS(on).typ}$ (@ $V_{GS}=4.5V$) | I_D |
|----------|----------|---------------------------------------|--|-------|
| EFM4407A | -30V | 9m Ω | 13m Ω | -12A |

Description

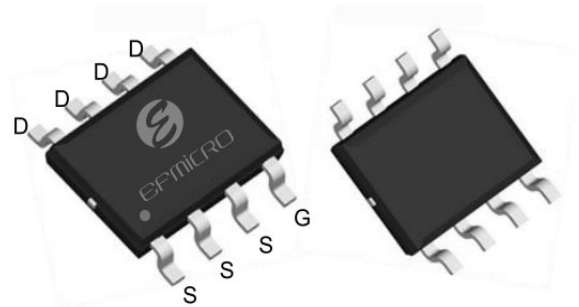
- The EFM4407A is the high cell density trenched
- P-ch MOSFETs which provide excellent
- RDSON and gate charge for most of the
- synchronous buck converter applications.
- The EFM4407A meet the RoHS and Green
- Product requirement, 100 % EAS guaranteed
- with full function reliability approved.

Application

- Super Low Gate Charge 100% EAS Guaranteed
- Green Device Available Excellent CdV/dt effect decline
- Advanced high cell density Trench technology



P-Channel MOSFET



SOP-8

Ordering Information:

| | |
|---------------------------|-------------|
| Part NO. | EFM4407A |
| Marking | 4407A ***** |
| Packing Information | REEL TAPE |
| Basic ordering unit (pcs) | 3000 |

Absolute Maximum Ratings ($T_C=25^\circ C$)

| Parameter | Symbol | Limit | Unit |
|--|----------------|------------|------------|
| Drain-Source Voltage | V_{DS} | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Drain Current-Continuous | I_D | -12 | A |
| Drain Current-Pulsed ^(Note 1) | I_{DM} | -60 | A |
| Maximum Power Dissipation | P_D | 3.1 | W |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55 To 150 | $^\circ C$ |

Thermal Characteristic

| | | | |
|---|-----------------|----|--------------|
| Thermal Resistance, Junction-to-Ambient ^(Note 2) | $R_{\theta JA}$ | 75 | $^\circ C/W$ |
|---|-----------------|----|--------------|

• Static Electrical Characteristics @ T_J = 25°C (unless otherwise stated)

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|---|---------------------|---|------|------|------|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V I _D =-250μA | -30 | -- | -- | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =-30V V _{GS} =0V | -- | -- | -1 | μA |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±20V V _{DS} =0V | -- | -- | ±100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} I _D =-250μA | -1.5 | -- | -3 | V |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} =-10V I _D =-12A | -- | 9 | 11 | mΩ |
| | | V _{GS} =-4.5V I _D =-10A | -- | 13 | 18 | mΩ |
| Forward Transconductance | g _{FS} | V _{DS} =-5V I _D =-10A | -- | 21 | -- | S |
| Gate Resistance | R _g | F=1.0MHz | -- | 2.4 | -- | Ω |
| Dynamic Characteristics (Note4) | | | | | | |
| Input Capacitance | C _{iss} | V _{DS} =-15V V _{GS} =0V F=1.0MHz | -- | 2060 | -- | PF |
| Output Capacitance | C _{oss} | | -- | 370 | -- | PF |
| Reverse Transfer Capacitance | C _{rss} | | -- | 295 | -- | PF |
| Switching Characteristics (Note 4) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | V _{DD} =-15V I _D =-10A V _{GS} =-10V R _G =3Ω, | -- | 11 | -- | nS |
| Turn-on Rise Time | t _r | | -- | 9.4 | -- | nS |
| Turn-Off Delay Time | t _{d(off)} | | -- | 24 | -- | nS |
| Turn-Off Fall Time | t _f | | -- | 12 | -- | nS |
| Total Gate Charge | Q _g | V _{DS} =-15V I _D =-12A V _{GS} =-10V | -- | 30 | -- | nC |
| Gate-Source Charge | Q _{gs} | | -- | 4.6 | -- | nC |
| Gate-Drain Charge | Q _{gd} | | -- | 10 | -- | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage (Note 3) | V _{SD} | V _{GS} =0V I _S =-1A | -- | -0.7 | -1 | V |
| Diode Forward Current (Note 2) | I _S | | -- | -- | -3 | A |

Note :

A: The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using < 300 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

F: The current rating is based on the t ≤ 10s thermal resistance rating.

G: E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_J=25°C.

• Typical Characteristics

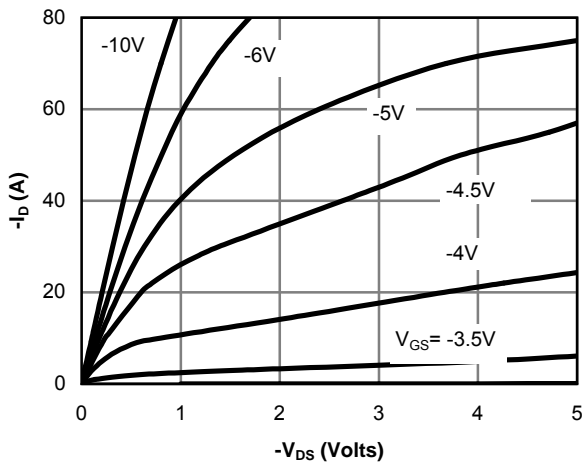


Figure 1: On-Region Characteristics

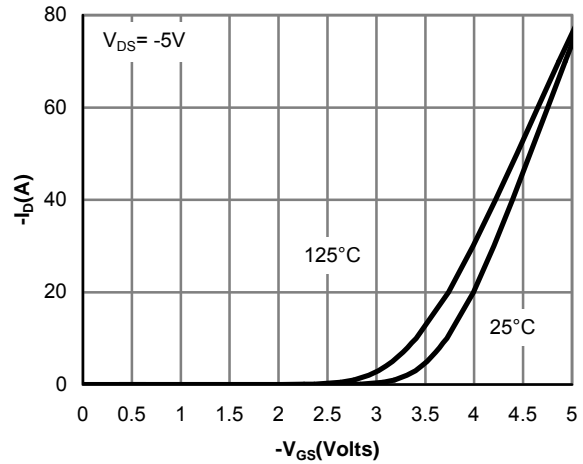


Figure 2: Transfer Characteristics

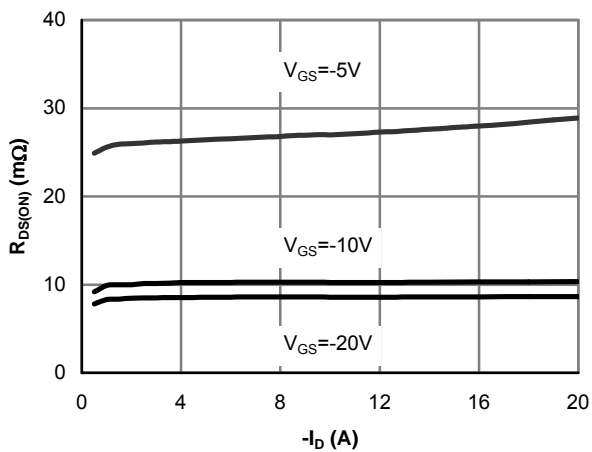


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

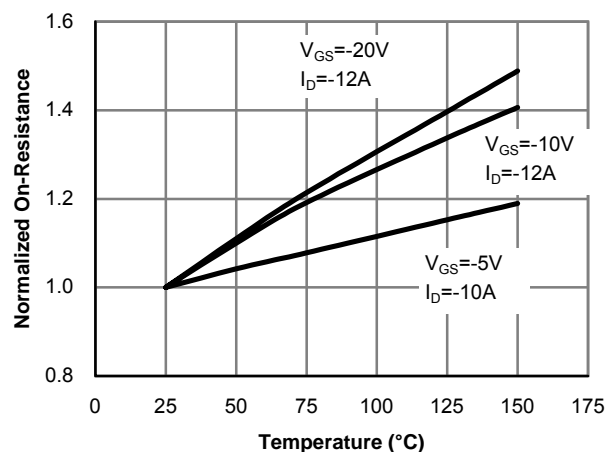


Figure 4: On-Resistance vs. Junction Temperature

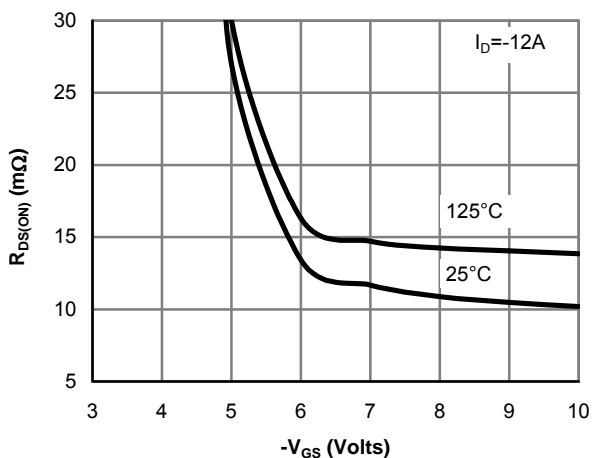


Figure 5: On-Resistance vs. Gate-Source Voltage

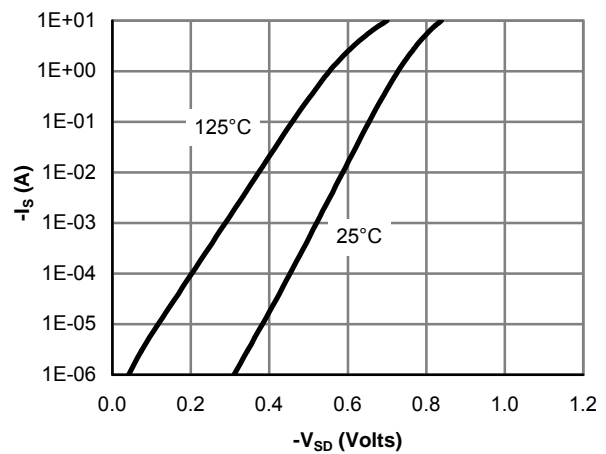


Figure 6: Body-Diode Characteristics

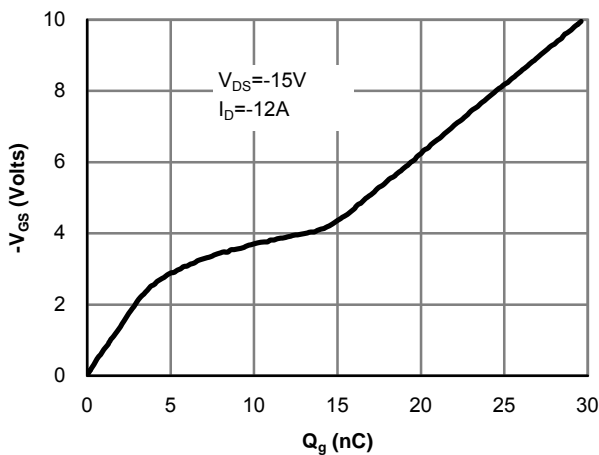


Figure 7: Gate-Charge Characteristics

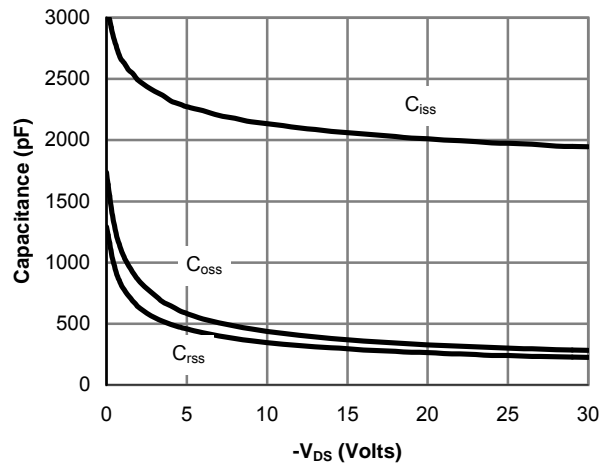


Figure 8: Capacitance Characteristics

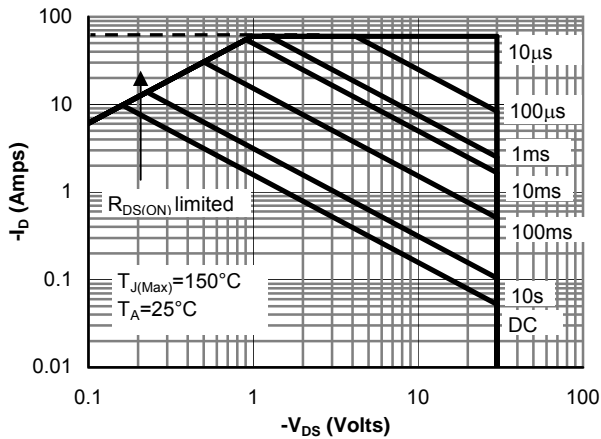


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

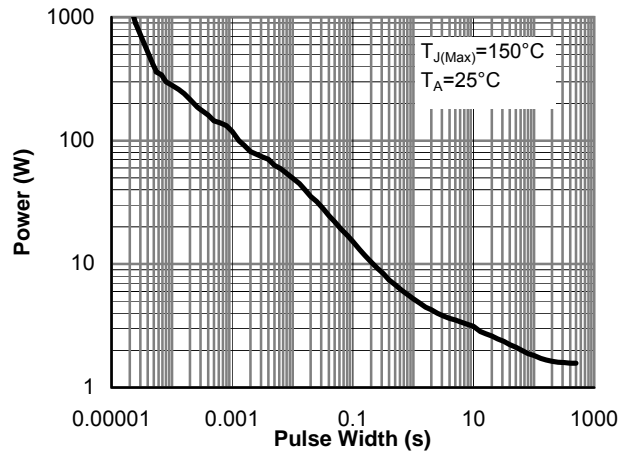


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

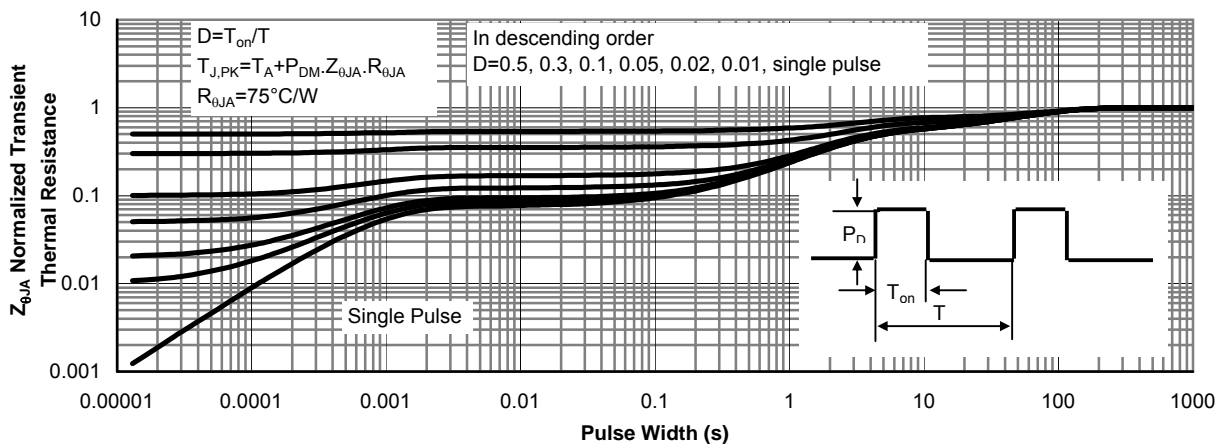
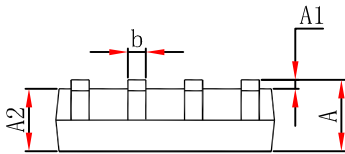
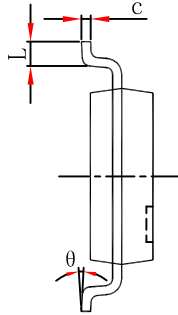
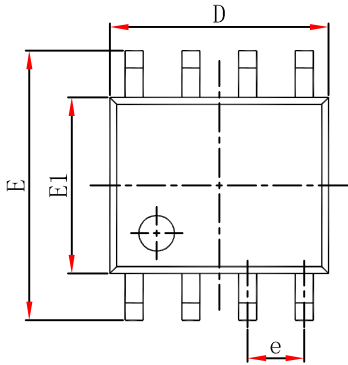
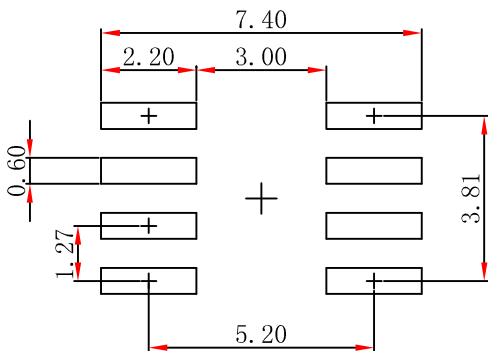


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)

SOP8 Package Outline Dimensions



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|----------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 1.450 | 1.750 | 0.053 | 0.069 |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 |
| A2 | 1.350 | 1.550 | 0.053 | 0.061 |
| b | 0.330 | 0.510 | 0.013 | 0.020 |
| c | 0.170 | 0.250 | 0.007 | 0.010 |
| D | 4.700 | 5.100 | 0.185 | 0.201 |
| e | 1.270 (BSC) | | 0.050 (BSC) | |
| E | 5.800 | 6.200 | 0.228 | 0.244 |
| E1 | 3.800 | 4.000 | 0.150 | 0.157 |
| L | 0.400 | 1.270 | 0.016 | 0.050 |
| θ | 0° | 8° | 0° | 8° |



Note:

1. Controlling dimension: in millimeters.
2. General tolerance: $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.